

<b>Notice of References Cited</b>	Application/Control No. 10/623,264	Applicant(s)/Patent Under Reexamination CHOU ET AL.	
	Examiner Joseph Haley	Art Unit 2653	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,944,109	09-2005	Wang et al.	369/53.26
*	B	US-6,975,578	12-2005	Endoh et al.	369/275.4
*	C	US-5,805,559	09-1998	Murakami et al.	369/47.5
*	D	US-2004/0125836	07-2004	Lai et al.	372/033
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

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